



The Jointed Test Finger is a precision test probe made according to Figure 2 (Fig. 2) of the IEC 61032 (Test probe B) and is used to simulate a human finger. It is also used by the standards of CSA, IRAM, UL and in most of the rules involved in the verification of accessibility to live parts.

Technical Parameters:

1. Knurled Finger Diameter:12 mm
2. Knurled Finger Length:80 mm
3. Baffle Plate Diameter:50 mm
4. Baffle Plate Length:100 mm
5. Baffle thickness:20 mm

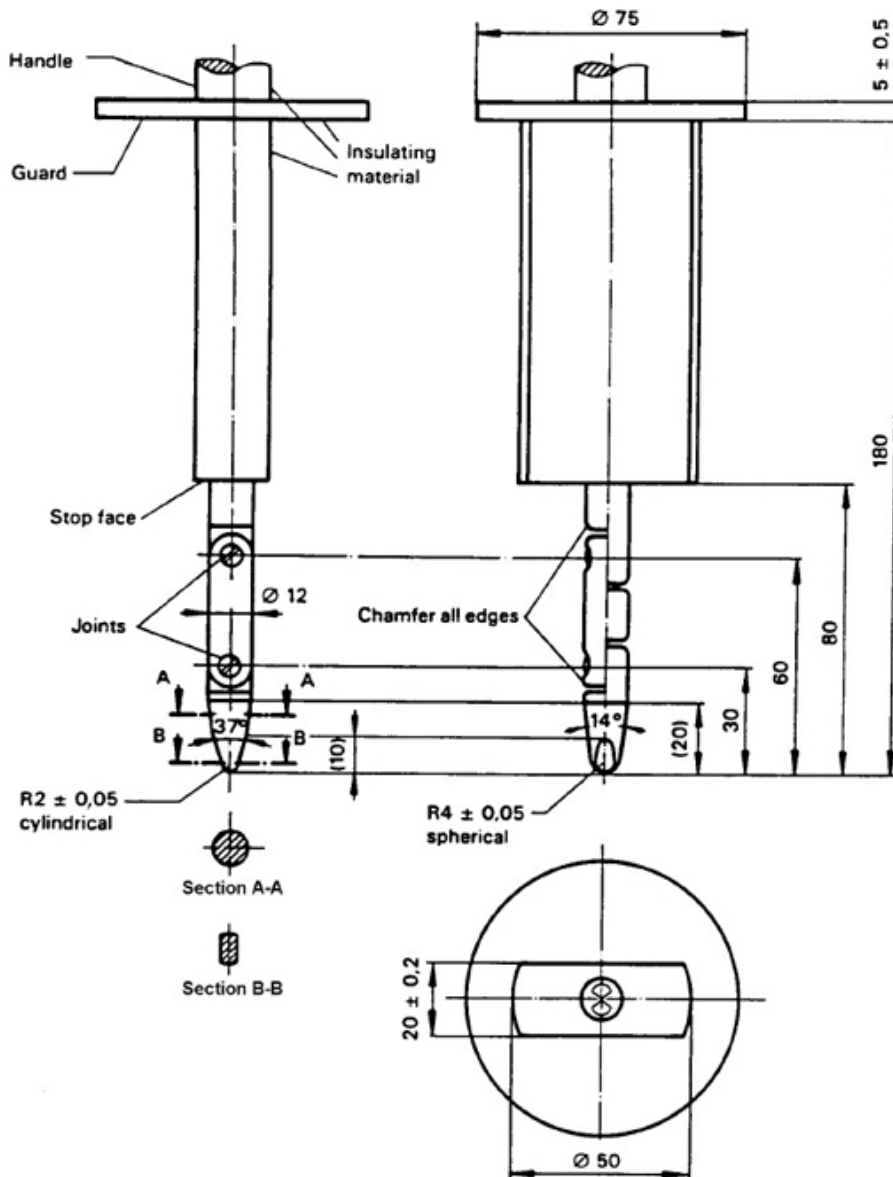
Application:

1. The joint part of The Standard Test Knurled Finger Probe can't touch the live parts or close to the dangerous parts, and 50 mm to 20 mm baffle plate cannot enter.
2. In the prevent electric shock test, wirings, power devices, and lighting devices are needed.

Notes:

Both joints shall permit movement in the same plane and the same direction through an angle of 90° with a 0° to +10° tolerance.

b)



Dimensions in millimetres

Material: metal, except where otherwise specified.

Tolerance on dimensions when no specific tolerance is given:

– on angles: $\begin{matrix} 0 \\ -10^\circ \end{matrix}$

– on linear dimensions: up to 25 mm: $\begin{matrix} 0 \\ -0,05 \end{matrix}$ mm; over 25 mm: $\pm 0,2$ mm.

Both joints shall permit movement in the same plane and the same direction through an angle of 90° with a 0° to $+10^\circ$ tolerance.

This probe is intended to verify the basic protection against access to hazardous parts. It is also used to verify the protection against access with a finger.

Figure 2 – Test probe B